

Notice of References Cited	Application/Control No. 10/608,222	Applicant(s)/Patent Under Reexamination HASEGAWA, SHUMPEI	
	Examiner Hai H. Huynh	Art Unit 3747	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,150,680 A	09-1992	Nishimura, Yutaka	123/399
*	B	US-5,307,777 A	05-1994	Sasajima et al.	123/399
*	C	US-5,381,771 A	01-1995	Leshner, Michael D.	123/436
*	D	US-5,448,974 A	09-1995	Toda, Atsushi	123/400
*	E	US-6,089,208 A	07-2000	Kowatari et al.	123/396
*	F	US-6,164,623 A	12-2000	Ito et al.	251/305
*	G	US-2004/0016419 A1	01-2004	Satou et al.	123/492
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP-36570	02-2004	Japan	Hasegawa	F02D-9/02
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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